

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination UNGASHE ET AL.	
		Examiner Peter G. O'Sullivan	Art Unit 1621	Page 1 of 3

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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		Examiner Peter G. O'Sullivan	Art Unit 1621	Page 2 of 3

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		Examiner Peter G. O'Sullivan	Art Unit 1621	Page 3 of 3

U.S. PATENT DOCUMENTS

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